

Notice of References Cited	Application/Control No. 10/628,500		Applicant(s)/Patent Under Reexamination MIYAZAWA ET AL.	
	Examiner Khiem D. Nguyen		Art Unit 2823	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0007301	01-2003	Ker et al.	361/111
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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